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Application/Control No.	Applicant(s)/Patent under Reexamination
10/516,693	INENAGA ET AL.
Examiner	Art Unit
Isiaka O. Akanhi	1.2877

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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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East (US-PGPUB; USPAT; USOCR; EPO)- See Update Search History Printout	1/3/2007	IOA		
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